



# STP100NF04 STB100NF04

N-channel 40V - 0.0043Ω - 120A - TO-220 - D<sup>2</sup>PAK  
STripFET™ II Power MOSFET

## General features

Type	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	P <sub>w</sub>
STP100NF04	40V	< 0.0046Ω	120A	300W
STB100NF04	40V	< 0.0046Ω	120A	300W

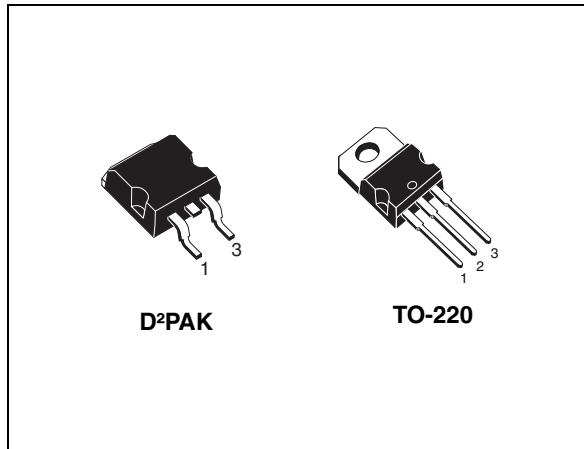
- Standard threshold drive
- 100% avalanche tested

## Description

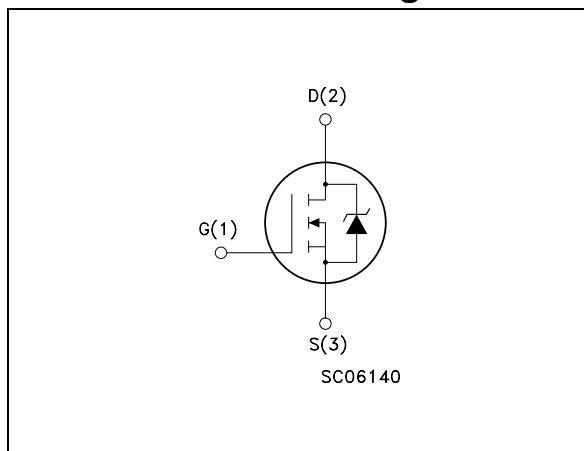
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

## Applications

- Switching application



## Internal schematic diagram



## Order codes

Part number	Marking	Package	Packaging
STB100NF04	B100NF04	D <sup>2</sup> PAK	Tape & Reel
STP100NF04	P100NF04	TO-220	Tube

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# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source Voltage ( $V_{GS}=0$ )	40	V
$V_{GS}$	Gate-source Voltage	$\pm 20$	V
$I_D^{(1)}$	Drain-current (continuous) at $T_c=25^\circ\text{C}$	120	A
$I_D^{(1)}$	Drain-current (continuous) at $T_c=100^\circ\text{C}$	120	A
$I_{DM}^{(2)}$	Drain-current (pulsed)	480	A
$P_{TOT}$	Total dissipation at $T_c=25^\circ\text{C}$	300	W
	Derating factor	2	$\text{W}/^\circ\text{C}$
$dv/dt^{(3)}$	Peak Diode Recovery voltage slope	6	$\text{V}/\mu\text{s}$
$E_{AS}^{(4)}$	Single Pulse Avalanche Energy	1.2	J
$T_j$ $T_{stg}$	Operating Junction Temperature Storage Temperature	-55 to 175	$^\circ\text{C}$

1. Current limited by package
2. Pulse width limited by safe operating area.
3.  $I_{SD} \leq 20\text{A}$ ,  $di/dt \leq 0\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})DSS}$ .  $T_j \leq T_{jmax}$
4. Starting  $T_j=25^\circ\text{C}$ ,  $I_D=60\text{A}$ ,  $V_{DD}=30\text{V}$

**Table 2. Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal Resistance Junction-case Max	0.5	$^\circ\text{C}/\text{W}$
$R_{thj-pcb}$	Thermal Resistance Junction-pcb Max	(see <a href="#">Figure 13</a> )	$^\circ\text{C}/\text{W}$
$R_{thj-amb}$	Thermal Resistance Junction-ambient (Free Air) Max	62.5	$^\circ\text{C}/\text{W}$
$T_I$	Maximum Lead Temperature For Soldering Purpose	300	$^\circ\text{C}$

## 2 Electrical characteristics

( $T_{CASE}=25^\circ\text{C}$  unless otherwise specified)

**Table 3. On/off**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown Voltage	$I_D=250\mu\text{A}$ , $V_{GS}=0$	40			V
$I_{DSS}$	Zero Gate Voltage Drain Current ( $V_{GS}=0$ )	$V_{DS}=\text{Max Rating}$ $V_{DS}=\text{Max Rating } T_c=125^\circ\text{C}$			1 10	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate-body Leakage Current ( $V_{DS}=0$ )	$V_{GS}=\pm 20\text{V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$	2		4	V
$R_{DS(on)}$	Static Drain-source On Resistance	$V_{GS}=10\text{V}$ , $I_D=50\text{A}$		0.0043	0.0046	$\Omega$

**Table 4. Dynamic**

Symbol	Parameter	Test conditions	Min	Typ.	Max.	Unit
$g_{fs}$	Forward Transconductance	$V_{DS}=15\text{V}$ , $I_D=50\text{A}$		150		S
$C_{iss}$ $C_{oss}$ $C_{rss}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS}=25\text{V}$ , $f=1\text{MHz}$ , $V_{GS}=0$	5100 1300 160			pF pF pF
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD}=32\text{V}$ , $I_D=120\text{A}$ $V_{GS}=10\text{V}$	110 35 70	150		nC nC nC
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	Turn-on Delay Time Rise time Turn-off delay Time Fall Time	$V_{DD}=20\text{V}$ , $I_D=60\text{A}$ $R_G=4.7\Omega$ $V_{GS}=10\text{V}$ (see <i>Figure 21</i> )	35 220 80 50			ns ns ns ns

**Table 5. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain Current			120	120	A
$I_{SDM}^{(1)}$	Source-drain Current (pulsed)			480	480	A
$V_{SD}^{(2)}$	Forward on Voltage	$I_{SD}=120A, V_{GS}=0$		1.3	1.3	V
$t_{rr}$	Reverse Recovery Time		75			ns
$Q_{rr}$	Reverse Recovery Charge		185			nC
$I_{RRM}$	Reverse recovery Current	$I_{SD}=120A, V_{DD}=20V,$ $dI/dt=100A/\mu s, T_j=150^\circ C$	5			A

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration=300μs, duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 1. Power Derating vs. Tc

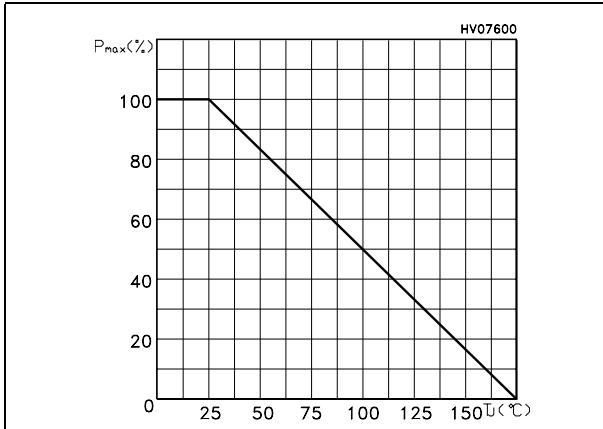


Figure 2. Max Id Current vs. Tc

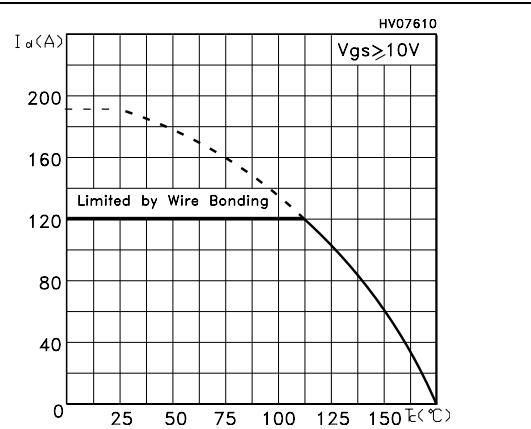


Figure 3. Output Characteristics

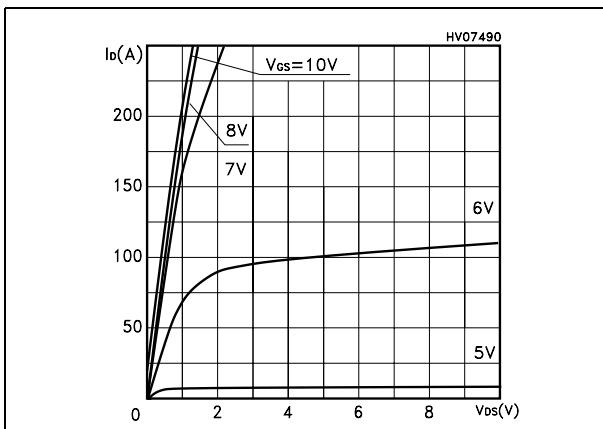


Figure 4. Transfer Characteristics

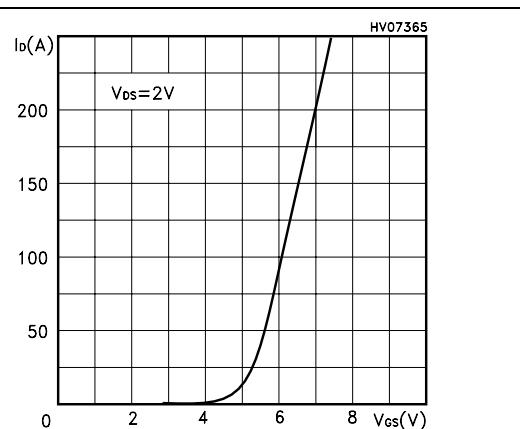


Figure 5. Transconductance

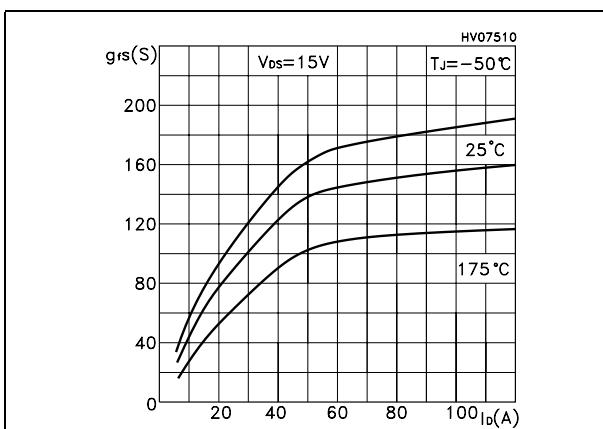
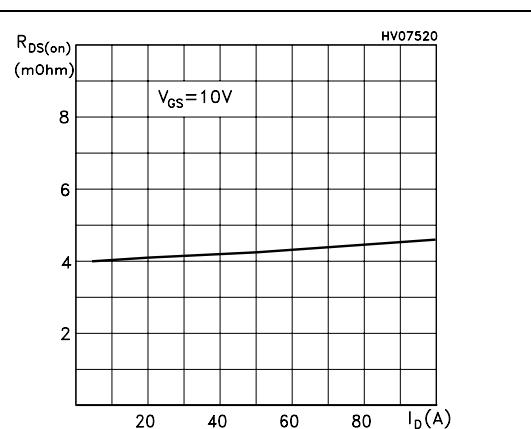
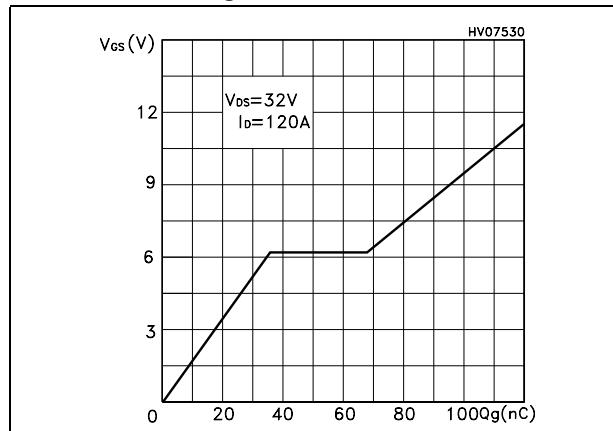
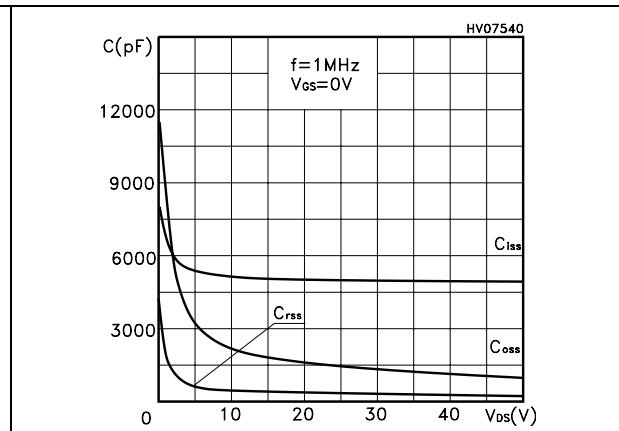
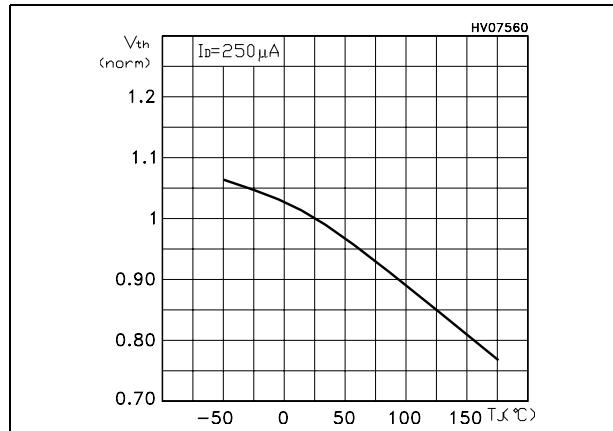
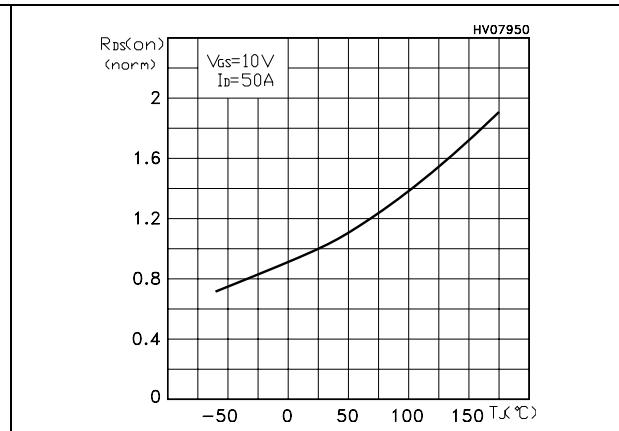
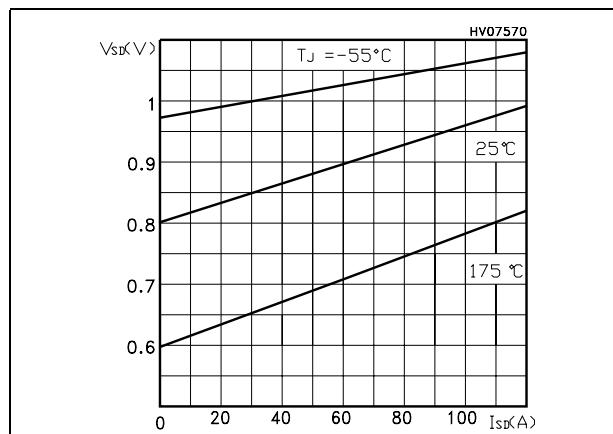
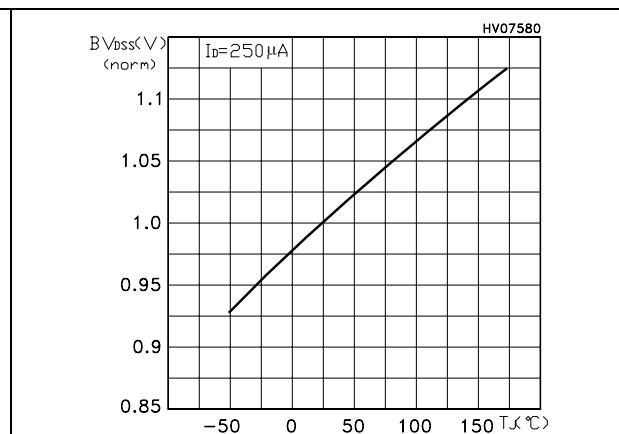
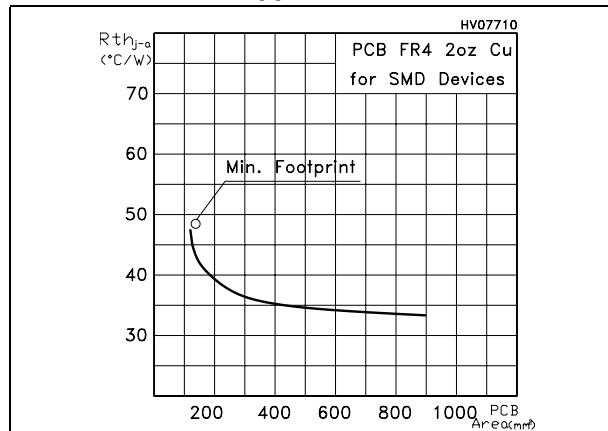


Figure 6. Static Drain-source on Resistance

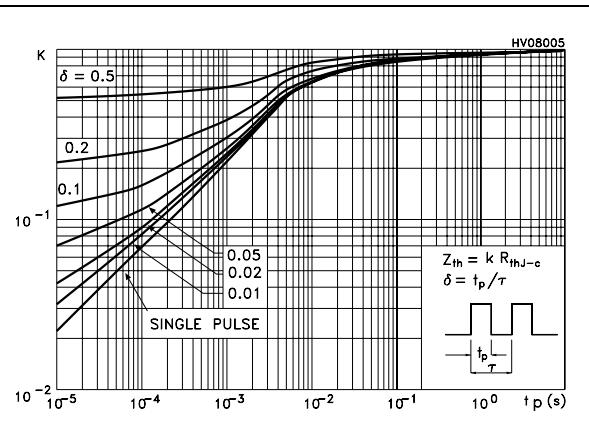


**Figure 7. Gate Charge vs. Gate-source Voltage****Figure 8. Capacitance Variations****Figure 9. Normalized Gate Threshold Voltage vs. Temperature****Figure 10. Normalized on Resistance vs. Temperature****Figure 11. Source-Drain Diode Forward Characteristics****Figure 12. Normalized BVdss vs. Temperature**

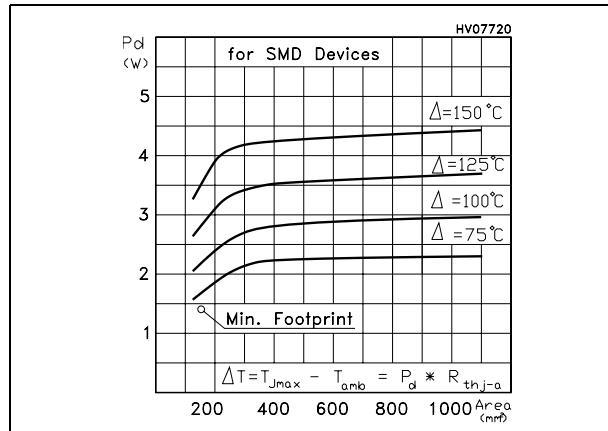
**Figure 13. Thermal Resistance  $R_{thj-pcb}$  vs. PCB Copper Area**



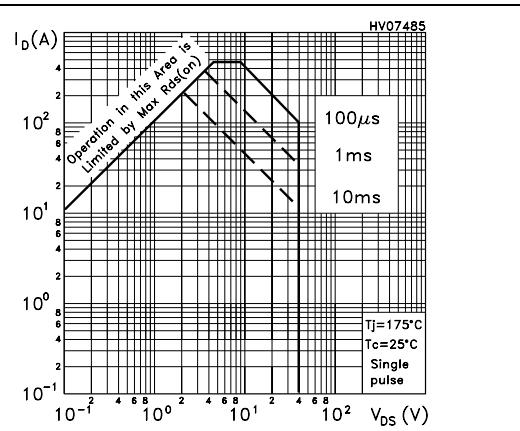
**Figure 14. Thermal Impedance**

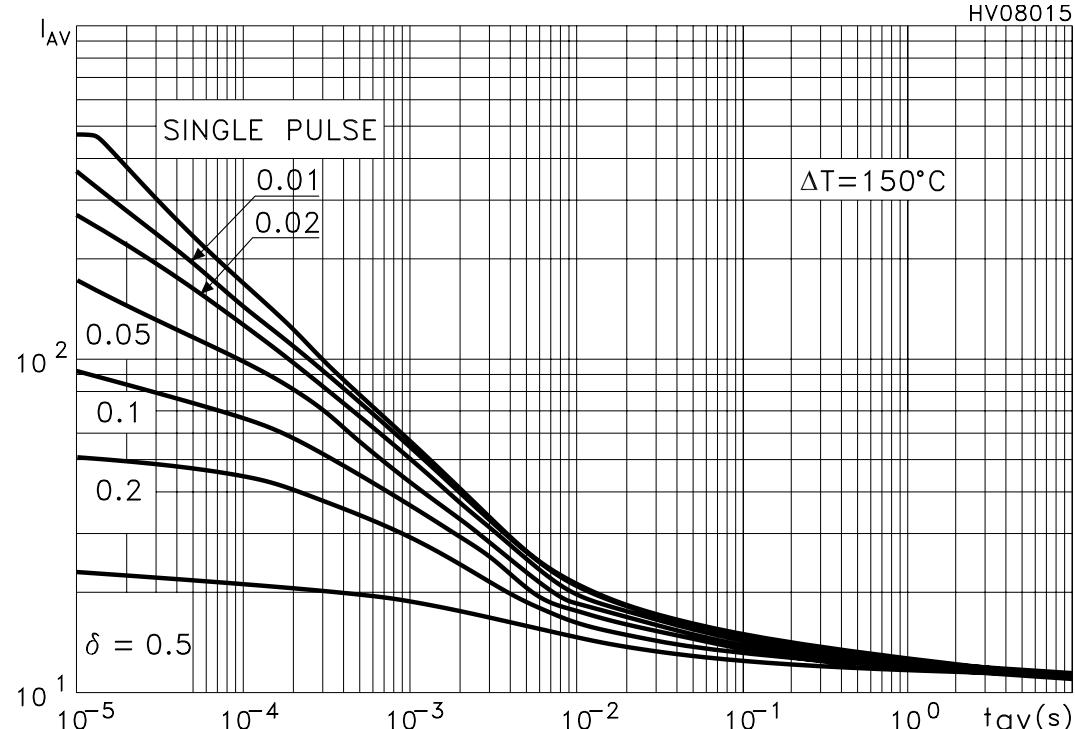


**Figure 15. Max Power Dissipation vs. PCB Copper Area**



**Figure 16. Safe Operating Area**



**Figure 17. Allowable I<sub>AV</sub> vs. Time in Avalanche**

The previous curve give the safe operating area for unclamped inductive loads, single pulse or repetitive, under the following conditions:

$$P_{D(AVE)} = 0.5 * (1.3 * BV_{DSS} * I_{AV})$$

$$E_{AS(AR)} = P_{D(AVE)} * t_{AV}$$

Where:

$I_{AV}$  is the Allowable Current in Avalanche

$P_{D(AVE)}$  is the Average Power Dissipation in Avalanche (Single Pulse)

$t_{AV}$  is the Time in Avalanche

To de rate above  $25^\circ C$ , at fixed  $I_{AV}$ , the following equation must be applied:

$$I_{AV} = 2 * (T_{jmax} - T_{CASE}) / (1.3 * BV_{DSS} * Z_{th})$$

Where:

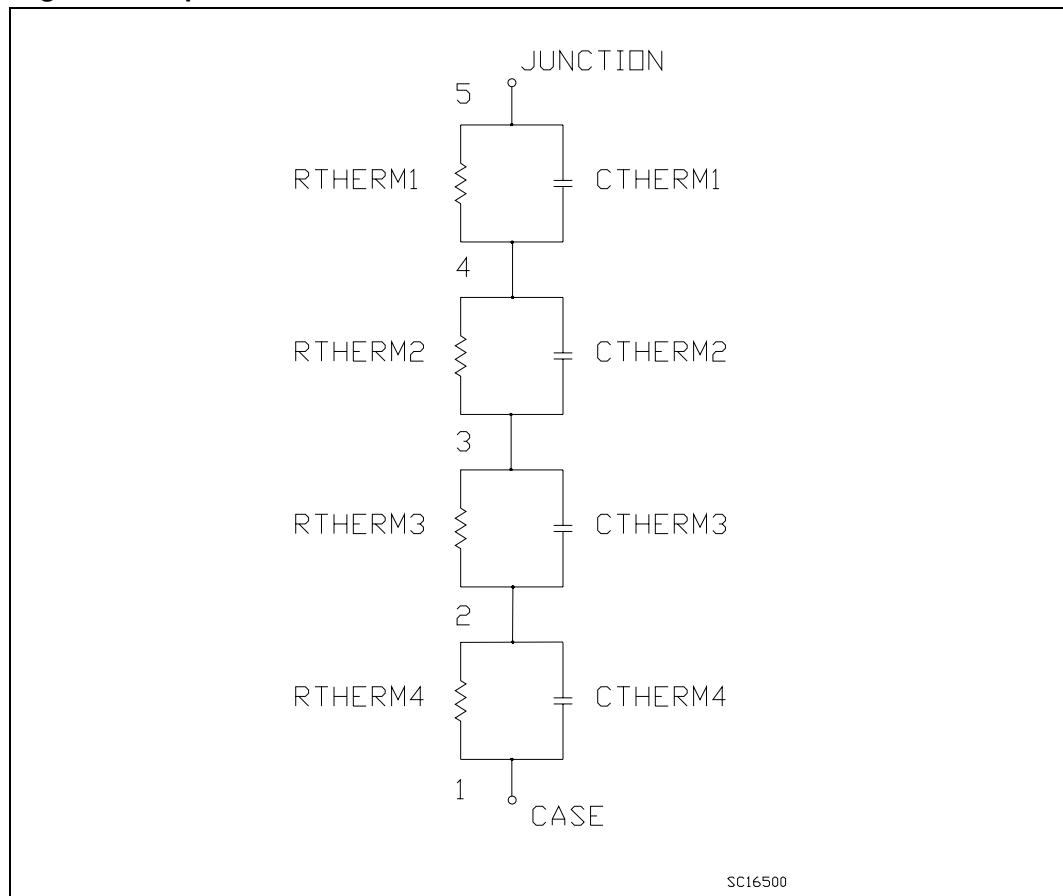
$Z_{th} = K * R_{th}$  is the value coming from Normalized Thermal Response at fixed pulse width equal to  $T_{AV}$

## 2.2 Spice thermal model

Table 6. Spice parameter

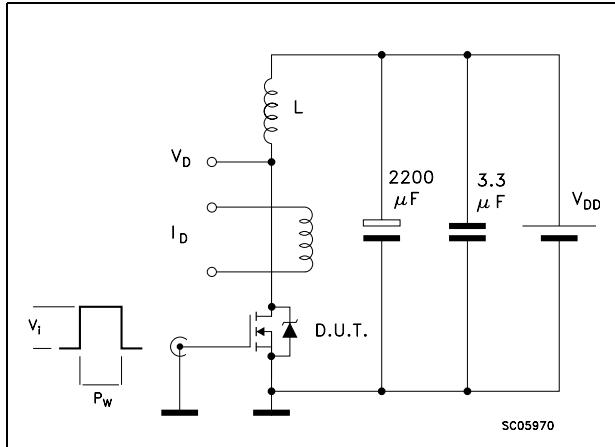
Parameter	Node	Value
CTHERM1	5 - 4	0.011
CTHERM1	4 - 3	0.0012
CTHERM3	3 - 2	0.05
CTHERM4	2 - 1	0.1
RTERM1	5 - 4	0.09
RTERM2	4 - 3	0.02
RTERM3	3 - 2	0.11
RTERM4	2 - 1	0.17

Figure 18. Spice model schematic

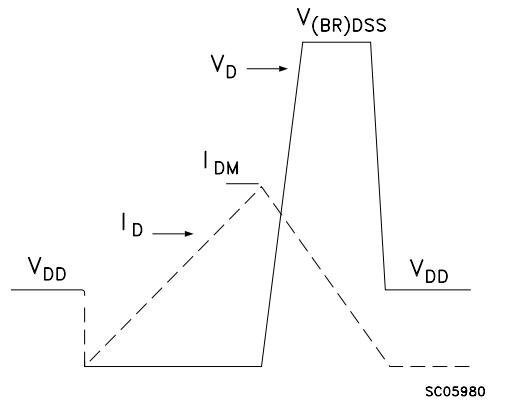


### 3 Test circuit

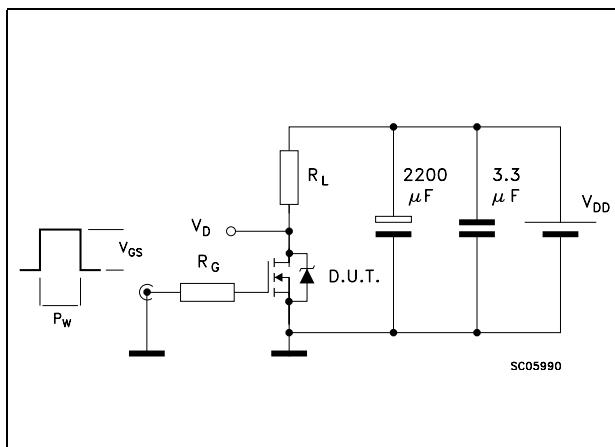
**Figure 19. Unclamped inductive load test circuit**



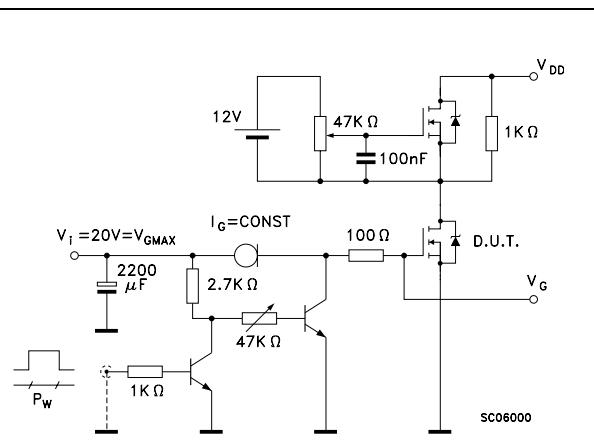
**Figure 20. Unclamped inductive waveform**



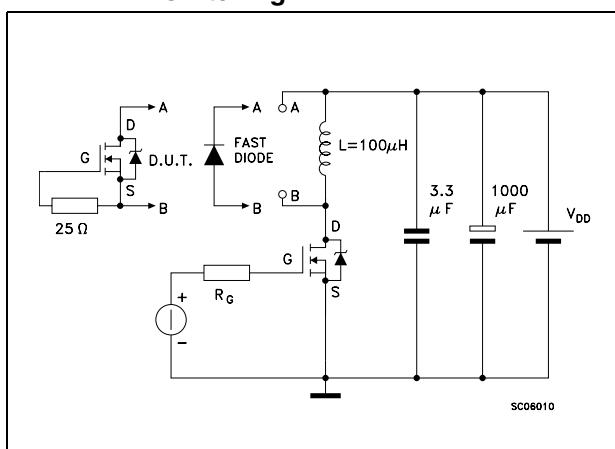
**Figure 21. Switching times test circuit for resistive load**



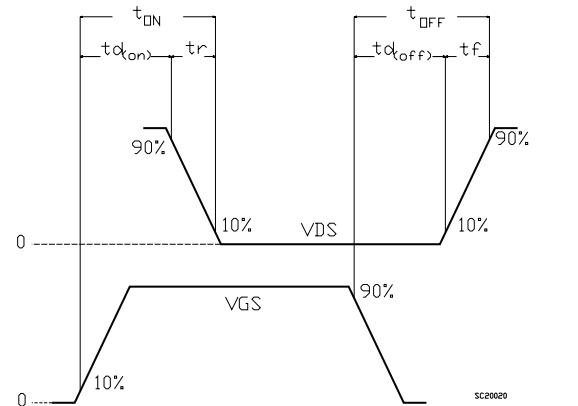
**Figure 22. Gate charge test circuit**



**Figure 23. Test circuit for inductive load switching**



**Figure 24. Switching time waveform**

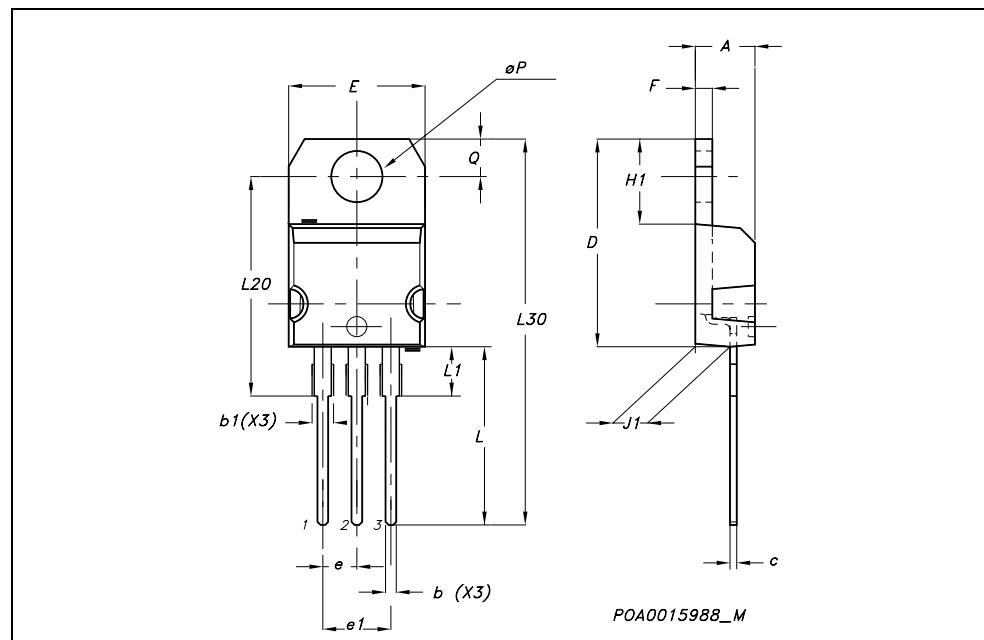


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com)

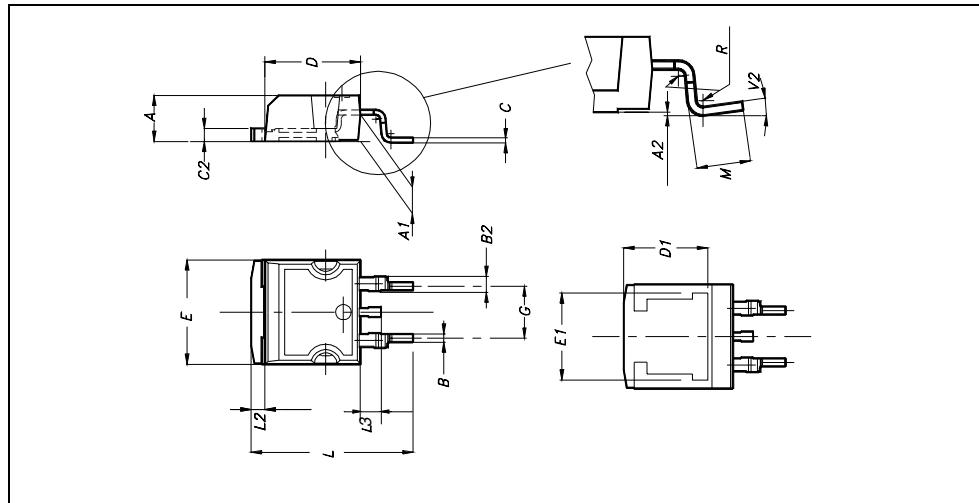
TO-220 MECHANICAL DATA					
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DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
c	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



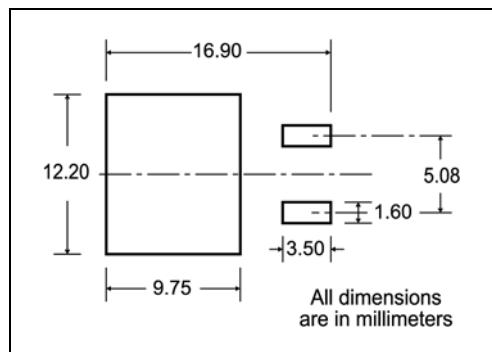
**D<sup>2</sup>PAK MECHANICAL DATA**

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
B	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
C	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
M	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0°		4°			



## 5 Packaging mechanical data

### D<sup>2</sup>PAK FOOTPRINT



### TAPE AND REEL SHIPMENT

REEL MECHANICAL DATA				
DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A			330	12.992
B	1.5		0.059	
C	12.8	13.2	0.504	0.520
D	20.2		0795	
G	24.4	26.4	0.960	1.039
N	100		3.937	
T		30.4		1.197
BASE QTY		BULK QTY		
1000		1000		

**TAPE MECHANICAL DATA**

DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A0	10.5	10.7	0.413	0.421
B0	15.7	15.9	0.618	0.626
D	1.5	1.6	0.059	0.063
D1	1.59	1.61	0.062	0.063
E	1.65	1.85	0.065	0.073
F	11.4	11.6	0.449	0.456
K0	4.8	5.0	0.189	0.197
P0	3.9	4.1	0.153	0.161
P1	11.9	12.1	0.468	0.476
P2	1.9	2.1	0.075	0.082
R	50		1.574	
T	0.25	0.35	0.0098	0.0137
W	23.7	24.3	0.933	0.956

\* on sales type

## 6 Revision history

**Table 7. Revision history**

Date	Revision	Changes
23-Mar-2005	2	New template
01-Mar-2006	3	Removed I <sup>2</sup> PAK and inserted D <sup>2</sup> PAK.
04-Sep-2006	4	New template, no content change
20-Feb-2007	5	Typo mistake on page 1

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